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/ Ruth Montalvo Date: 03/07/02

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Customer No. 026418

Attorney's Docket No.: JG-YY-5116/500569.20081

Applicant(s) Masaaki TERASHIMA, et al.

U.S. Application No.: 10/006,169

Group No.:

Filed: December 6, 2001

Examiner:

For: DEVICE FOR MEASURING IONIC ACTIVITIES

Commissioner of Patents
Washington, D. C. 20231

INFORMATION DISCLOSURE STATEMENT

SIR:

Applicant hereby submits the following references:

	Document Number	Date	Name and/or Country
AA	4,571,293	2/18/1986	US
AB	4,789,435	12/6/1988	US
AC	4,053,381	10/11/1977	US
AD	4,171,246	10/16/1979	US
AE	4,219,968	9/2/1980	US

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Accompanying this Information Disclosure Statement and form PTO-1449 are
copies of the aforementioned documents.

This submission is not an admission that the information disclosed in the documents
is material to the patentability of the invention disclosed and/or claimed in the
above-identified application.

Respectfully submitted,

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Enclosures:
PTO-1449; 5 documents

• LIST OF PRIOR ART CITED BY APPLICANT
(Filed on March 7, 2002)

Docket No. JG-YY-5116/500569.20081
 Applicant(s): Masaaki TERASHIMA, et al.
 Application No. 10/006,169
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 Examiner: --

U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub- Class	Filing Date Appropriate
AN	AA	4,571,293	2/18/1986	Seshimoto et al	204	408 13	
AN	AB	4,789,435	12/6/1988	Seshimoto et al	204	1T	205/789
AN	AC	4,053,381	10/11/1977	Hambien, et al.	204	195 4 416	
AN	AD	4,171,246	10/16/1979	Hambien, et al.	204	1T	205/778.5
AN	AE	4,219,968	9/2/1980	Sakai, et al.	49	40	
	AF						

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	CLASS	Sub- Class	Translation YES	NO
AL							
AM							
AN							
AO							
AP							
AQ							
AR							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AT	
AU	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.